

1. Carrier Concentration

a) Intrinsic Semiconductors

- Pure single-crystal material

For an intrinsic semiconductor, the concentration of electrons in the conduction band is equal to the concentration of holes in the valence band.

We may denote,

n_i : intrinsic electron concentration

p_i : intrinsic hole concentration

However,

$$n_i = p_i$$

Simply,

n_i :intrinsic carrier concentration, which refers to either the intrinsic electron or hole concentration

Commonly accepted values of n_i at $T = 300^\circ\text{K}$

Silicon	$1.5 \times 10^{10} \text{ cm}^{-3}$
Gallium arsenide	$1.8 \times 10^6 \text{ cm}^{-3}$
Germanium	$2.4 \times 10^{13} \text{ cm}^{-3}$

b) Extrinsic Semiconductors

- Doped material

The doping process can greatly alter the electrical characteristics of the semiconductor. This doped semiconductor is called an extrinsic material.

n-Type Semiconductors (negatively charged electron by adding donor)

p-Type Semiconductors (positively charged hole by adding acceptor)

c) Mass-Action Law

n_0 : thermal-equilibrium concentration of electrons

p_0 : thermal-equilibrium concentration of holes

$$n_0 p_0 = n_i^2 = f(T) \text{ (function of temperature)}$$

The product of n_0 and p_0 is always a constant for a given semiconductor material at a given temperature.

d) Equilibrium Electron and Hole Concentrations

Let,

n_0 : thermal-equilibrium concentration of electrons

p_0 : thermal-equilibrium concentration of holes

n_d : concentration of electrons in the donor energy state

p_a : concentration of holes in the acceptor energy state

N_d : concentration of donor atoms

N_a : concentration of acceptor atoms

N_d^+ : concentration of positively charged donors (ionized donors)

N_a^- : concentration of negatively charged acceptors (ionized acceptors)

By definition,

$$N_d^+ = N_d - n_d$$

$$N_a^- = N_a - p_a$$

by the charge neutrality condition,

$$n_0 + N_a^- = p_0 + N_d^+$$

or

$$n_0 + (N_a - p_a) = p_0 + (N_d - n_d)$$

assume complete ionization,

$$p_a = n_d = 0$$

then, eq # becomes,

$$n_0 + N_a = p_0 + N_d$$

by eq # and the Mass-Action law ($n_0 p_0 = n_i^2$)

$$n_0 = \frac{1}{2} \{ (N_d - N_a) + ((N_d - N_a)^2 + 4n_i^2)^{1/2} \}, \text{ where } N_d > N_a \text{ (n-type)}$$

$$p_0 = \frac{1}{2} \{ (N_a - N_d) + ((N_a - N_d)^2 + 4n_i^2)^{1/2} \}, \text{ where } N_a > N_d \text{ (p-type)}$$

$$n_0 = p_0 = n_i, \text{ where } N_a = N_d \text{ (intrinsic)}$$

If $N_d - N_a \gg n_i$,

then

$$n_0 = N_d - N_a, p_0 = n_i^2 / (N_d - N_a)$$

If $N_a - N_d \gg n_i$,

then

$$p_0 = N_a - N_d, n_0 = n_i^2 / (N_a - N_d)$$

Example 1)

Determine the thermal equilibrium electron and hole concentrations for a given doping concentration.

Consider an n-type silicon semiconductor at $T = 300^\circ\text{K}$ in which $N_d = 10^{16} \text{ cm}^{-3}$ and $N_a = 0$. The intrinsic carrier concentration is assumed to be $n_i = 1.5 \times 10^{10} \text{ cm}^{-3}$.

- Solution

The majority carrier electron concentration is

$$n_o = \frac{1}{2} \{ (N_d - N_a) + ((N_d - N_a)^2 + 4n_i^2)^{1/2} \} \approx 10^{16} \text{ cm}^{-3}$$

The minority carrier hole concentration is

$$p_o = n_i^2 / n_o = (1.5 \times 10^{10})^2 / 10^{16} = 2.25 \times 10^4 \text{ cm}^{-3}$$

- Comment

$N_d \gg n_i$, so that the thermal-equilibrium majority carrier electron concentration is essentially equal to the donor impurity concentration. The thermal-equilibrium majority and minority carrier concentrations can differ by many orders of magnitude.

Example 2)

Determine the thermal equilibrium electron and hole concentrations for a given doping concentration.

Consider an germanium sample at $T = 300^\circ\text{K}$ in which $N_d = 5 \times 10^{13} \text{ cm}^{-3}$ and $N_a = 0$.

Assume that $n_i = 2.4 \times 10^{13} \text{ cm}^{-3}$.

- Solution

The majority carrier electron concentration is

$$n_o = \frac{1}{2} \{ (5 \times 10^{13}) + ((5 \times 10^{13})^2 + 4(2.4 \times 10^{13})^2)^{1/2} \} = 5.97 \times 10^{13} \text{ cm}^{-3}$$

The minority carrier hole concentration is

$$p_o = n_i^2 / n_o = (2.4 \times 10^{13})^2 / (5.97 \times 10^{13}) = 9.65 \times 10^{12} \text{ cm}^{-3}$$

- Comment

If the donor impurity concentration is not too different in magnitude from the intrinsic carrier concentration, the thermal-equilibrium majority carrier electron concentration is influenced by the intrinsic concentration.

Example 3)

Determine the thermal equilibrium electron and hole concentrations in a compensated n-type semiconductor.

Consider a silicon semiconductor at $T = 300^\circ\text{K}$ in which $N_d = 10^{16} \text{ cm}^{-3}$ and $N_a = 3 \times 10^{15} \text{ cm}^{-3}$. Assume that $n_i = 1.5 \times 10^{10} \text{ cm}^{-3}$.

- Solution

The majority carrier electron concentration is

$$n_o = \frac{1}{2} \{ (10^{16} - 3 \times 10^{15}) + ((10^{16} - 3 \times 10^{15})^2 + 4(1.5 \times 10^{10})^2)^{1/2} \} \approx 7 \times 10^{15} \text{ cm}^{-3}$$

The minority carrier hole concentration is

$$p_o = n_i^2 / n_o = (1.5 \times 10^{10})^2 / (7 \times 10^{15}) = 3.21 \times 10^4 \text{ cm}^{-3}$$

- Comment

If we assume complete ionization and if $N_d - N_a \gg n_i$, the the majority carrier electron concentration is, to a very good approximation, just the difference between the donor and acceptor concentrations.

